

### SEMITOP<sup>®</sup>E1

### Sixpack Open Emitter

#### SK30GD07E3ETE1

#### Features\*

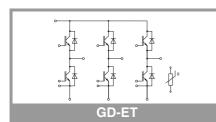
- Optimized design for superior thermal performance
- Low inductive design
- Press-Fit contact technology
- 650V Trench IGBT3 (E3)
- Robust and soft switching CAL4F diode technology
- Integrated NTC temperature sensor
- UL recognized file no. E 63 532

#### **Typical Applications**

- Motor drives
- Servo drives
- Air conditioning
- Auxiliary InvertersUPS

#### Remarks

• Recommended  $T_{j,op}$ =-40 ...+150 °C



Absolute	Maximum Rating	S				
Symbol	Conditions	Values			Unit	
Inverter -	IGBT					
V <sub>CES</sub>	T <sub>j</sub> = 25 °C			650		V
lc	λ <sub>paste</sub> =0.8 W/(mK)	T <sub>s</sub> = 70 °C	32			Α
	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 100 °C		26		Α
	λ <sub>paste</sub> =2.5 W/(mK)	T <sub>s</sub> = 70 °C		39		Α
	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 100 °C		31		Α
I <sub>Cnom</sub>		-		30		Α
I <sub>CRM</sub>				60		Α
V <sub>GES</sub>				-20 20		V
t <sub>psc</sub>	$V_{CC} = 360 V$ $V_{GE} \le 15 V$ $V_{CES} \le 650 V$	T <sub>j</sub> = 150 °C	6		μs	
Tj		-		-40 175		°C
Inverse -	Diode					
V <sub>RRM</sub>	T <sub>i</sub> = 25 °C			650		V
l <sub>F</sub>	λ <sub>paste</sub> =0.8 W/(mK)	T <sub>s</sub> = 70 °C	29		Α	
	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 100 °C		23		Α
l <sub>F</sub>	λ <sub>paste</sub> =2.5 W/(mK)	T <sub>s</sub> = 70 °C		34		Α
T <sub>j</sub> = 175 °C		T <sub>s</sub> = 100 °C		27		
I <sub>FRM</sub>		1		60		Α
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms, sin 180°	°, T <sub>j</sub> = 150 °C	150			Α
Tj				-40 175		°C
Module						
I <sub>t(RMS)</sub>	, ΔT <sub>terminal</sub> at PCB	oint = 30 K, per pin	pin 30			Α
T <sub>stg</sub>		module without TIM -40 125			°C	
V <sub>isol</sub>	AC, sinusoidal, t =	1 min	2500		V	
Characte	1		I			1
Symbol	Conditions		min.	typ.	max.	Unit
Inverter -						
V <sub>CE(sat)</sub>	$I_{\rm C} = 30 \rm{A}$	T <sub>j</sub> = 25 °C		1.45	1.87	V
	V <sub>GE</sub> = 15 V	T; = 150 °C		1.70	2.10	v

Symbol	Conditions		min.	typ.	max.	Unit	
Inverter - IGBT							
V <sub>CE(sat)</sub>	$I_{\rm C} = 30  {\rm A}$	T <sub>i</sub> = 25 °C		1.45	1.87	V	
()	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 150 °C		1.70	2.10	V	
V <sub>CE0</sub>	chiplevel	T <sub>j</sub> = 25 °C		0.90	1.00	V	
		T <sub>j</sub> = 150 °C		0.82	0.90	V	
r <sub>CE</sub>	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25 °C		18	29	mΩ	
	chiplevel	T <sub>j</sub> = 150 °C		29	40	mΩ	
V <sub>GE(th)</sub>	$V_{GE} = V_{CE}, I_C = 0.43 \text{ mA}$		5.1	5.8	6.4	V	
I <sub>CES</sub>	$V_{GE} = 0 V, V_{CE} = 65$	0 V, T <sub>j</sub> = 25 °C			1	mA	
Cies	V/ 05.V/	f = 1 MHz		1.63		nF	
C <sub>oes</sub>	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		0.11		nF	
C <sub>res</sub>		f = 1 MHz		0.05		nF	
$Q_{G}$	V <sub>GE</sub> = -15V15V			301		nC	
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			0		Ω	
t <sub>d(on)</sub>	$\begin{array}{l} V_{CC} = 300 \ V \\ I_{C} = 30 \ A \\ R_{G \ on} = 12 \ \Omega \\ R_{G \ off} = 12 \ \Omega \\ di/dt_{on} = 1200 \ A/\mu s \end{array}$	T <sub>j</sub> = 150 °C		20		ns	
t <sub>r</sub>		T <sub>j</sub> = 150 °C		24		ns	
Eon		T <sub>j</sub> = 150 °C		0.91		mJ	
t <sub>d(off)</sub>		T <sub>j</sub> = 150 °C		174		ns	
t <sub>f</sub>	di/dt <sub>off</sub> = 620 A/µs	T <sub>j</sub> = 150 °C		39		ns	
E <sub>off</sub>	dv/dt = 5000 V/μs V <sub>GE</sub> = +15/-15 V	T <sub>j</sub> = 150 °C		0.81		mJ	
R <sub>th(j-s)</sub>	per IGBT, λ <sub>paste</sub> =0.8 W/(mK)			1.45		K/W	
R <sub>th(j-s)</sub>	per IGBT, $\lambda_{paste}$ =2.5 W/(mK)			1.09		K/W	



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  diode technology
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#### **Typical Applications**

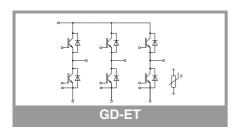
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- Servo drives
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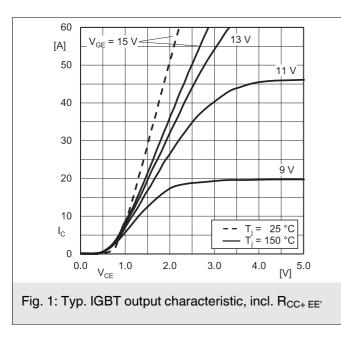
#### Remarks

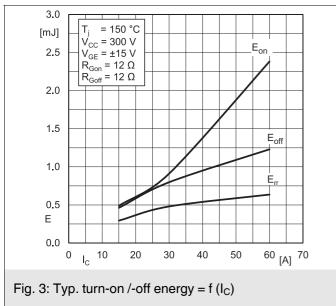
• Recommended  $T_{j,op}$ =-40 ...+150 °C

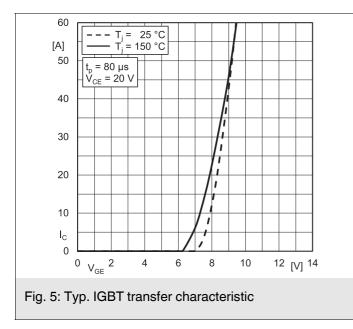
ristics					
Conditions		min.	typ.	max.	Unit
Diode					
I <sub>F</sub> = 30 A	T <sub>j</sub> = 25 °C		1.60	2.06	V
chiplevel	T <sub>j</sub> = 150 °C		1.69	2.21	V
ahinlayal	T <sub>j</sub> = 25 °C		1.04	1.24	V
- chipievei	T <sub>j</sub> = 150 °C		0.85	0.99	V
chiplevel	T <sub>j</sub> = 25 °C		19	27	mΩ
	T <sub>j</sub> = 150 °C		28	41	mΩ
$I_{\rm F} = 30  {\rm A}$	T <sub>j</sub> = 150 °C		33		Α
V <sub>GE</sub> = -15 V V <sub>CC</sub> = 300 V	T <sub>j</sub> = 150 °C		2.7		μC
di/dt <sub>off</sub> = 1000 A/µs	T <sub>j</sub> = 150 °C		0.48		mJ
per Diode, $\lambda_{paste}$ =0.8 W/(mK)			1.75		K/W
per Diode, $\lambda_{\text{paste}}$ =2.5 W/(mK)			1.38		K/W
			30		nH
to heatsink		1.6		2.3	Nm
			25		g
ristics					
Conditions		min.	typ.	max.	Unit
ure Sensor					
	ConditionsDiode $I_F = 30 \text{ A}$ chiplevelchiplevelchiplevelchiplevelIF = 30 AVGE = -15 VVCC = 300 Vdi/dtoff = 1000 A/µsper Diode, $\lambda_{paste}=0$ .per Diode, $\lambda_{paste}=2$ .to heatsinkristicsConditions	ConditionsDiode $I_F = 30 \text{ A}$ $T_j = 25 \text{ °C}$ chiplevel $T_j = 150 \text{ °C}$ chiplevel $T_j = 25 \text{ °C}$ chiplevel $T_j = 25 \text{ °C}$ chiplevel $T_j = 150 \text{ °C}$ lF = 30 A $T_j = 150 \text{ °C}$ VGE = -15 V $V_{CC} = 300 \text{ V}$ di/dt <sub>off</sub> = 1000 A/µs $T_j = 150 \text{ °C}$ per Diode, $\lambda_{paste}=0.8 \text{ W/(mK)}$ per Diode, $\lambda_{paste}=2.5 \text{ W/(mK)}$ to heatsinkristicsConditions	$\begin{tabular}{ c c c } \hline Conditions & min. \\ \hline Diode & & & & & \\ \hline I_F = 30 \ A & & & & & \\ \hline I_F = 30 \ A & & & & \\ \hline T_j = 150 \ ^\circ C & & & \\ \hline T_j = 150 \ ^\circ C & & & \\ \hline T_j = 150 \ ^\circ C & & & \\ \hline T_j = 150 \ ^\circ C & & & \\ \hline T_j = 150 \ ^\circ C & & \\ \hline V_{GE} = -15 \ V & & \\ \hline V_{CC} = 300 \ V & & \\ \hline di/dt_{off} = 1000 \ A/\mu s & & \\ \hline per \ Diode, \ \lambda_{paste} = 0.8 \ W/(mK) & & \\ \hline per \ Diode, \ \lambda_{paste} = 2.5 \ W/(mK) & & \\ \hline to \ heatsink & & 1.6 \\ \hline \hline ristics & & \\ \hline Conditions & min. \\ \hline \end{tabular}$	$\begin{tabular}{ c c c c } \hline Conditions & min. typ. \\ \hline Diode & & & & & & & & & & & & & & & & & & &$	$\begin{tabular}{ c c c c c } \hline $ \min. typ. max. \\ \hline $ \min. typ. max \\ \hline $ \min. typ. typ. typ \\ \hline $ \min. typ. typ. typ. typ \\ \hline $ \min. typ. typ \\$

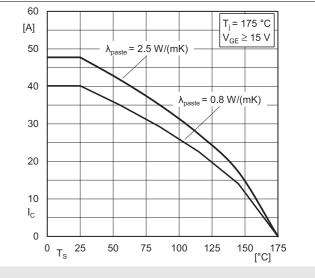
R <sub>100</sub>	T <sub>c</sub> =100°C (R <sub>25</sub> =5 kΩ)	493 ± 5%	Ω			
B <sub>25/85</sub>	R <sub>(T)</sub> =R <sub>25</sub> *exp[B <sub>25/85</sub> *(1/T-1/298)], T[K]	3420	K			

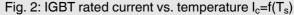












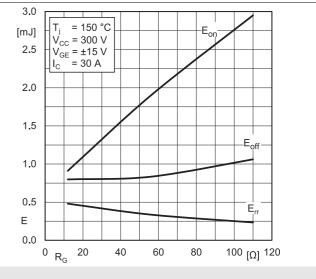
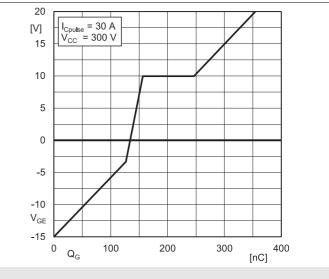
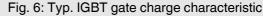


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$ 





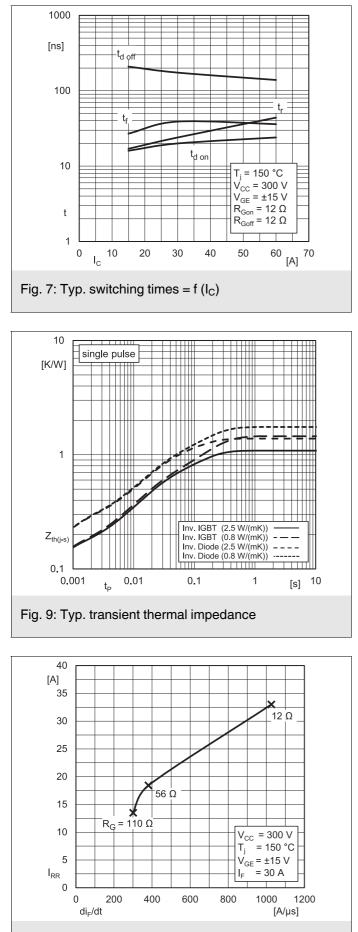
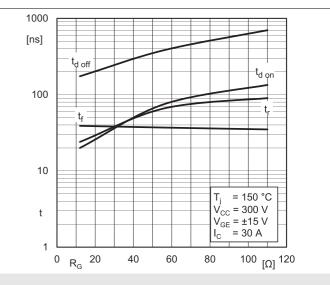
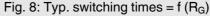


Fig. 11: Typ. Inv. diode peak reverse recovery current





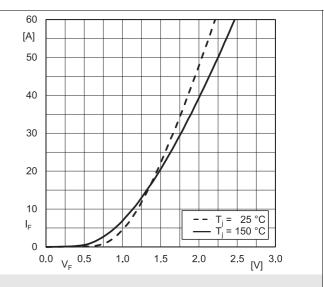
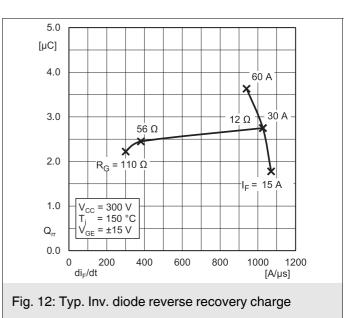
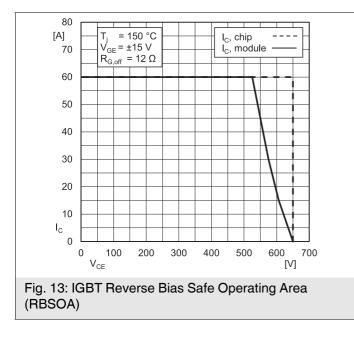
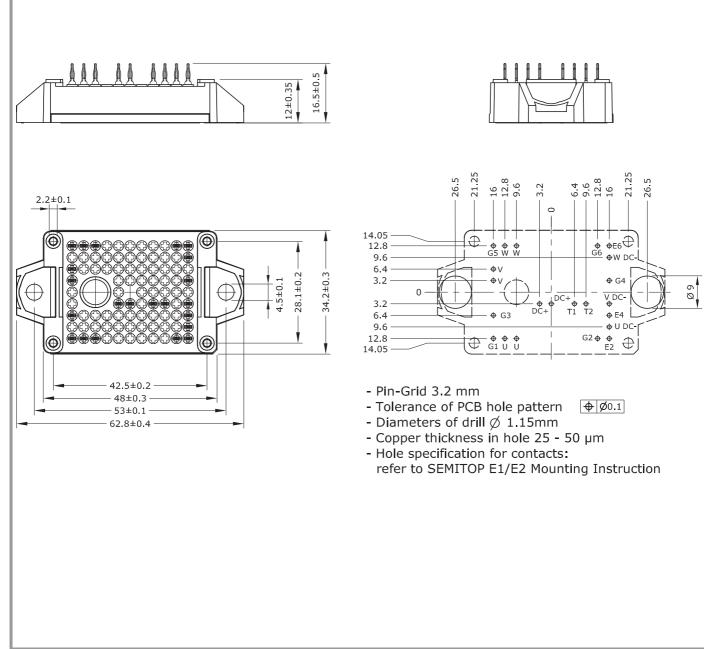


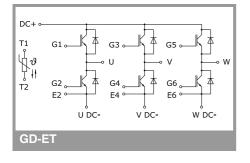
Fig. 10: Typ. Inv. diode forward charact., incl.  $R_{CC^{\prime}+\,EE^{\prime}}$ 







#### SEMITOP®E1



This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

#### **\*IMPORTANT INFORMATION AND WARNINGS**

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